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Application/Control No.	Applicant(s)/Patent under Reexamination
10/525,378	TAKEI, KEN
Examiner	Art Unit
Tho G. Phan	2821

SEARCHED						
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Class	Subclass	Date	Examiner			
343	702,722,7 49,850,85 1,858,860	9/28/2007	ТР			
343	895	9/28/2007	TP			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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	nce search attached	9/28/2007	TP		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
search history attached	9/28/2007	TP		
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